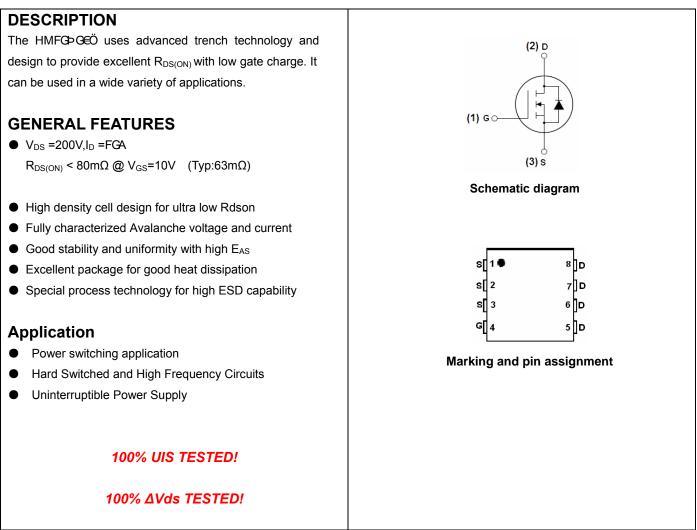
# N-Channel Enhancement Mode Power MOSFET



### Package Marking And Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
HMFGÞG€Ö	HMFGÞG€Ö	ÖØÞÍÝÎĖÌŠ	-	-	-

### Absolute Maximum Ratings (TC=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	Vds	200	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Drain Current-Continuous	Ι <sub>D</sub>	F2	A
Drain Current-Continuous(T <sub>C</sub> =100℃)	I <sub>D</sub> (100℃)	8	A
Pulsed Drain Current	I <sub>DM</sub>	36	А
Maximum Power Dissipation	PD	150	W
Single pulse avalanche energy (Note 5)	E <sub>AS</sub>	250	mJ
Operating Junction and Storage Temperature Range	TJ,TSTG	-55 To 175	°C

### **Thermal Characteristic**

Thermal Resistance, Junction-to-Case(Note 2)	R <sub>θJC</sub>	1	°C/W
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#### Electrical Characteristics (TC=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250µA	200	220	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =200V,V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)	·					
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250µA	2.5	3.2	4	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =15A	-	63	80	mΩ
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> =50V,I <sub>D</sub> =15A	30	-	-	S
Dynamic Characteristics (Note4)	·					
Input Capacitance	C <sub>lss</sub>			4200		PF
Output Capacitance	Coss	V <sub>DS</sub> =25V,V <sub>GS</sub> =0V, F=1.0MHz		163		PF
Reverse Transfer Capacitance	C <sub>rss</sub>			75		PF
Switching Characteristics (Note 4)	·					
Turn-on Delay Time	t <sub>d(on)</sub>		-	10	-	nS
Turn-on Rise Time	tr	V <sub>DD</sub> =100V,I <sub>D</sub> =15A	-	18	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =10V, $R_{GEN}$ =2.5 $\Omega$	-	22	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	5	-	nS
Total Gate Charge	Qg	)/ _100)/  _15A		60		nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> =100V,I <sub>D</sub> =15A, V <sub>GS</sub> =10V		19		nC
Gate-Drain Charge	Q <sub>gd</sub>	V <sub>GS</sub> =10V		17		nC
Drain-Source Diode Characteristics	·					
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =11A	-	-	1.2	V
Diode Forward Current (Note 2)	Is	-	-	-	12	А
Reverse Recovery Time	t <sub>rr</sub>	TJ = 25°C, IF = 15A	-	90	-	nS
Reverse Recovery Charge	Qrr	di/dt = 100A/µs(Note3)	-	300	-	nC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negli	gible (turi	n-on is do	minated b	y LS+LD

### Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.

**2.** Surface Mounted on FR4 Board,  $t \le 10$  sec.

**3.** Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2%.

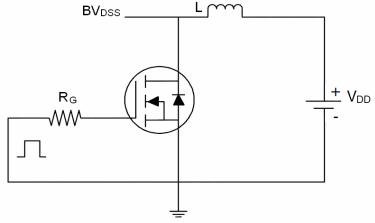
4. Guaranteed by design, not subject to production

**5.** EAS condition: Tj=25 $^{\circ}$ C,V<sub>DD</sub>=100V,V<sub>G</sub>=10V,L=0.5mH,Rg=25 $\Omega$ 

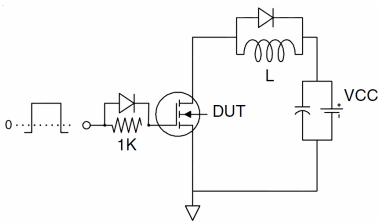


# **Test circuit**

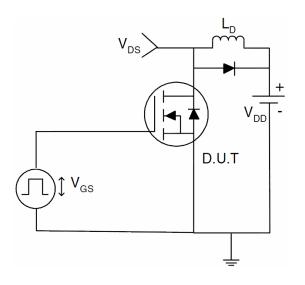
1) E<sub>AS</sub> test Circuits



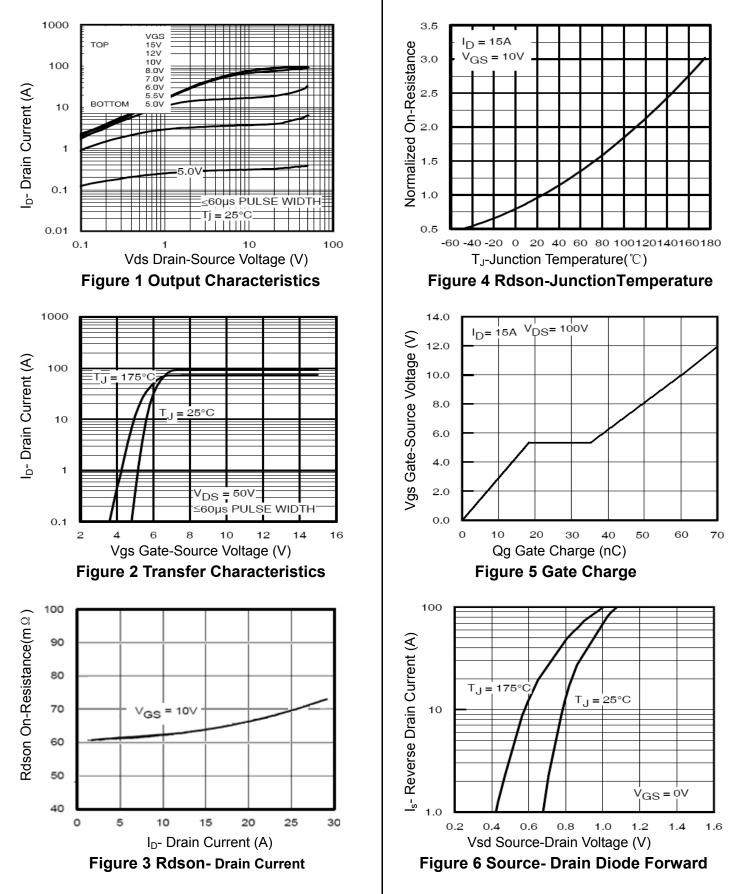
### 2) Gate charge test Circuit:



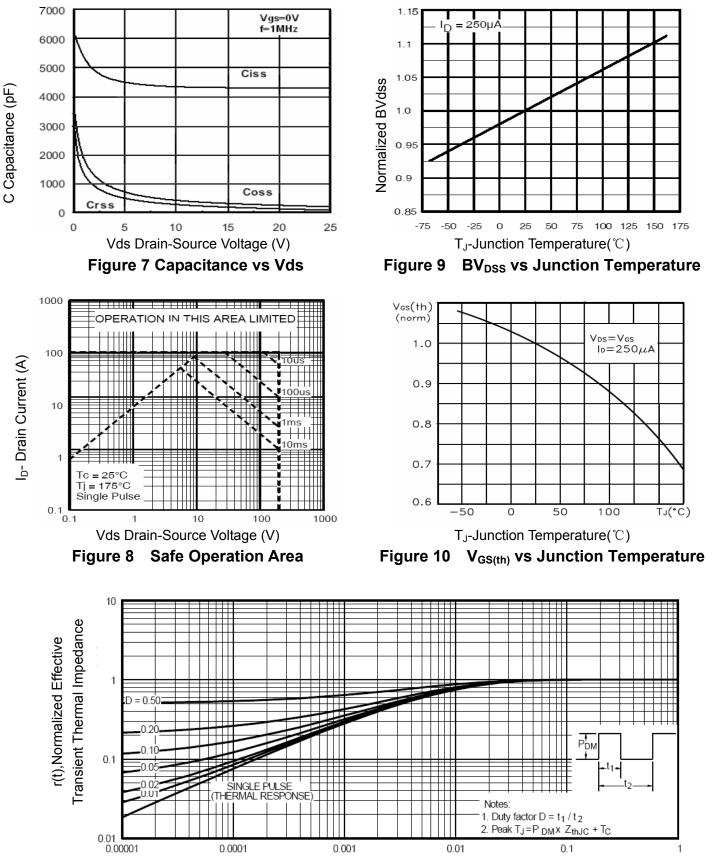
3) Switch Time Test Circuit:



# **TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (Curves)**



H&M 华之美半导体 SEMI www.hmsemi.com



Square Wave Pluse Duration(sec)

Figure 11 Normalized Maximum Transient Thermal Impedance

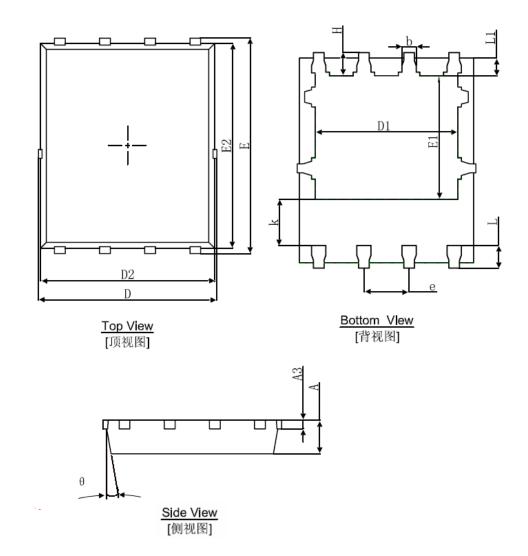
PT Fœ Œ



i.



# DFN5X6-8L Package Information



Cumahaal	Dimensions	In Millimeters	Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
А	0.900	1.000	0.035	0.039	
A3	0.254	REF.	0.010REF.		
D	4.944	5.096	0.195	0.201	
E	5.974	6.126	0.235	0.241	
D1	3.910	4.110	0.154	0.162	
E1	3.375	3.575	0.133	0.141	
D2	4.824	4.976	0.190	0.196	
E2	5.674	5.826	0.223	0.229	
k	1.190	1.390	0.047	0.055	
b	0.350	0.450	0.014	0.018	
е	1.270TYP.		0.050	TYP.	
L	0.559	0.711	0.022	0.028	
L1	0.424	0.576	0.017	0.023	
Н	0.574	0.726	0.023	0.029	
θ	8°	12°	8°	12°	

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